

# SFR9214TM-VB Datasheet

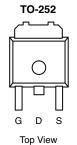
# **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	- 250				
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = - 10 V	1.0			
Q <sub>g</sub> (Max.) (nC)	38				
Q <sub>gs</sub> (nC)	8.0				
Q <sub>gd</sub> (nC)	18				
Configuration	Single				

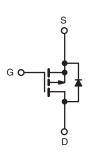
#### **FEATURES**

- · Advanced Process Technology
- Dynamic dV/dt Rating
- 150 °C Operating Temperature
- · Fast Switching
- P-Channel
- Fully Avalanche Rated
- Lead (Pb)-free Available





Drain Connected to Tab



P-Channel MOSFET

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	- 250	V	
Gate-Source Voltage			$V_{GS}$	± 20	V	
Continuous Drain Current	\/ ot 10 \/	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	1-	- 6.0		
	VGS at - 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	- 4.0	Α	
Pulsed Drain Current <sup>a</sup>			$I_{DM}$	- 16		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	520	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	- 4.1	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	3.5	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			$P_{D}$	85	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	o°C	
dering Recommendations (Peak Temperature) for 10 s			300 <sup>d</sup>			
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Forque				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T<sub>J</sub> = 25 °C, L = 62 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AS</sub> = 4.1 A (see fig. 12). c. I<sub>SD</sub>  $\leq$  4.1 A, dl/dt  $\leq$  640 A/ $\mu$ s, V<sub>DD</sub>  $\leq$  V<sub>DS</sub>, T<sub>J</sub>  $\leq$  150 °C. d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.6	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		- 250	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I <sub>D</sub> = 1 mA		- 0.27	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	- 4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zava Cata Valtaria Brain Comment		V <sub>DS</sub> = - 250 V, V <sub>GS</sub> = 0 V		-	-	- 25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 200	V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	- 250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 2.5 A <sup>b</sup>	-	1.0	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	- 50 V, I <sub>D</sub> = - 4.1 A <sup>b</sup>	2.2	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$ ,		680	-	
Output Capacitance	C <sub>oss</sub>		$V_{DS} = -25 V,$	-	170	-	- pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	.0 MHz, see fig. 5	-	40	-	
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	$Q_g$			ı	-	38	nC
Gate-Source Charge	$Q_{gs}$	V <sub>GS</sub> = - 10 V	$I_D = -4.1 \text{ A}, V_{DS} = -200 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	1	-	8.0	
Gate-Drain Charge	$Q_{gd}$		gramma va	-	-	18	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = - 130 V, $I_{D}$ = - 4.1 A, $R_{G}$ = 12 $\Omega$ , $R_{D}$ = 31 $\Omega$ , see fig. 10 <sup>b</sup>		-	12	-	- ns
Rise Time	t <sub>r</sub>			-	23	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	34	-	
Fall Time	t <sub>f</sub>			-	21	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	ml l
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						•
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		i	-	- 4.1	Α
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	- 16	,,
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C,	$I_S = -4.1 \text{ A}, V_{GS} = 0 \text{ V}^b$	-	-	- 6.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- T <sub>J</sub> = 25 °C, I <sub>F</sub> = - 4.1 A, dl/dt = -100 A/μs <sup>b</sup>		-	190	290	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			-	1.5	2.2	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )				_D)	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

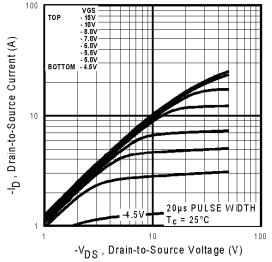


Fig. 1 - Typical Output Characteristics,  $T_C$  = 25  $^{\circ}C$ 

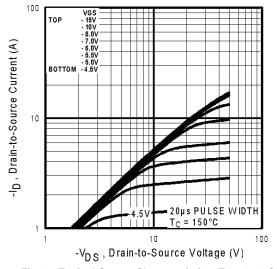


Fig. 2 - Typical Output Characteristics, T  $_{\text{C}}\text{=}$  150  $^{\circ}\text{C}$ 

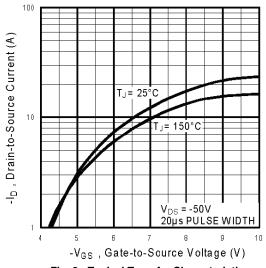


Fig. 3 - Typical Transfer Characteristics

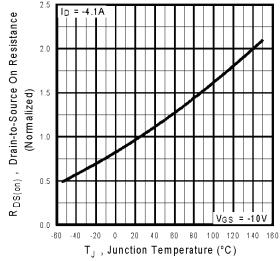


Fig. 4 - Normalized On-Resistance vs. Temperature



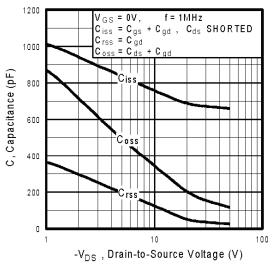


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

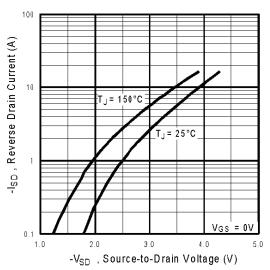


Fig. 7 - Typical Source-Drain Diode Forward Voltage

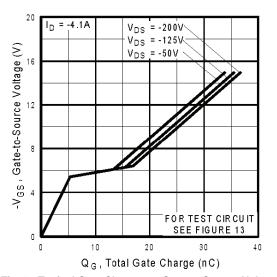


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

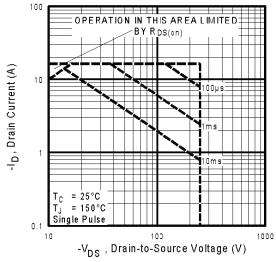


Fig. 8 - Maximum Safe Operating Area



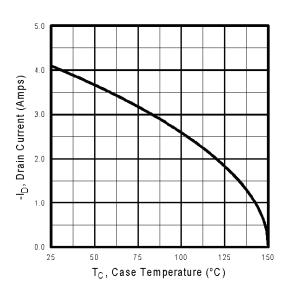


Fig. 9 - Maximum Drain Current vs. Case Temperature

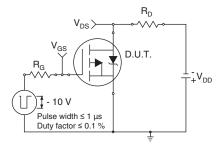


Fig. 10a - Switching Time Test Circuit

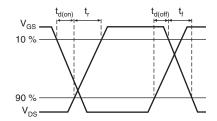


Fig. 10b - Switching Time Waveforms

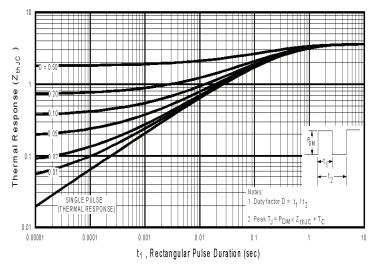


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

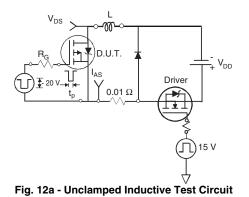
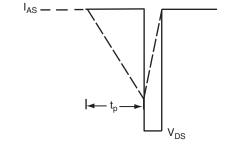


Fig. 12b - Unclamped Inductive Waveforms





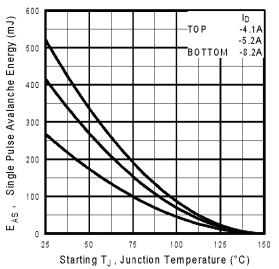


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

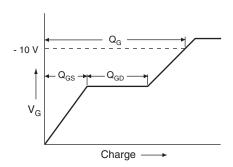


Fig. 13a - Basic Gate Charge Waveform

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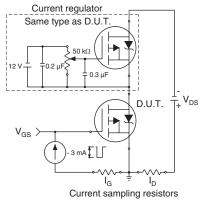
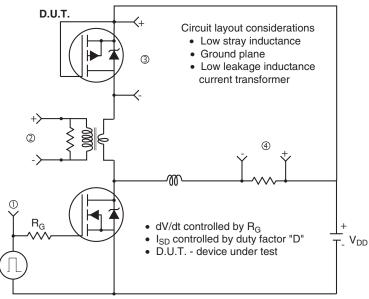


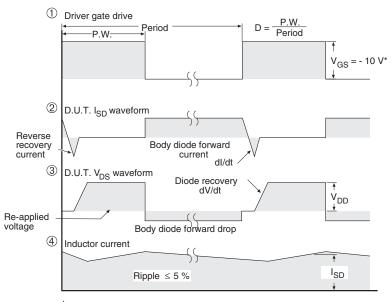
Fig. 13b - Gate Charge Test Circuit



# Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

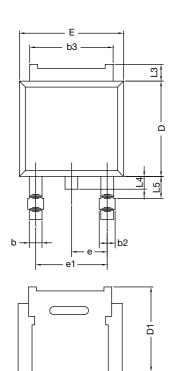


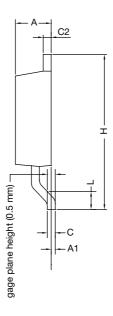
\*  $V_{GS} = -5 \text{ V}$  for logic level and -3 V drive devices

Fig. 14 - For P-Channel



# **TO-252AA CASE OUTLINE**





	MILLIN	METERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	=	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090 BSC		
e1	4.56 BSC		0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347					

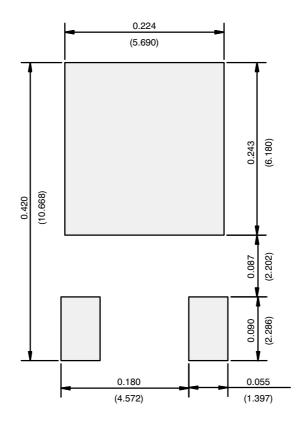
#### Note

• Dimension L3 is for reference only.



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## **RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**



Recommended Minimum Pads Dimensions in Inches/(mm)



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